

Search Notes



Application/Control No.

10/538,256

Examiner

Sang Y. Paik

Applicant(s)/Patent under Reexamination

GRABOWSKI ET AL.

Art Unit

3742

SEARCHED

Class	Subclass	Date	Examiner
392	386- 406		
	324 - 337		
261	139 142		
	016 65		
		8/1/07	JP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
GTJ TGT SEARCHED	8/1/07	JP